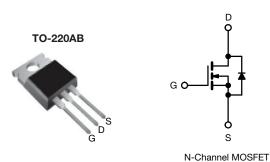


Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	1000			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	5.0		
Q _g max. (nC)	80			
Q _{gs} (nC)	10			
Q _{gd} (nC)	42			
Configuration	Single			

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free	IRFBG30PbF			
Lead (Pb)-free and halogen-free	IRFBG30PbF-BE3			

ABSOLUTE MAXIMUM RATINGS (T_C	= 25 °C, unl	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	1000	V	
Gate-source voltage			V_{GS}	± 20		
Continuous drain current	V at 10 V	T _C = 25 °C	,	3.1	А	
	V _{GS} at 10 V	T _C = 100 °C	I _D	2.0		
Pulsed drain current ^a			I _{DM}	12	1	
Linear derating factor				1.0	W/°C	
Single pulse avalanche energy ^b			E _{AS}	280	mJ	
Repetitive avalanche current a			I _{AR}	3.1	Α	
Repetitive avalanche energy ^a			E _{AR}	13	mJ	
Maximum power dissipation	T _C = 25 °C		P_{D}	125	W	
Peak diode recovery dV/dt ^c			dV/dt	1.0	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) ^d	For 10 s			300		
Mounting torque	6.00.0*1	C 00 - 1 M0 1		10	lbf ⋅ in	
	6-32 or M3 screw			1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 55 mH, R_g = 25 Ω , I_{AS} = 3.1 A (see fig. 12)
- c. $I_{SD} \le 3.1$ A, $dI/dt \le 80$ A/ μ s, $V_{DD} \le 600$, $T_J \le 150$ °C
- d. 1.6 mm from case

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	62		
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0$	1000	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	1.4	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V$	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		-	4.0	V
Gate-source leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
7	,	V _{DS} = 1000 V, V _{GS} = 0 V		-	-	100	μА
Zero gate voltage drain current	I _{DSS}	V _{DS} = 800 V, V	V _{DS} = 800 V, V _{GS} = 0 V, T _J = 125 °C		-	500	
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.9 A ^b	-	-	5.0	Ω
Forward transconductance	9 _{fs}	V _{DS} = 10 V, I _D = 1.9 A ^b		2.1	-	-	S
Dynamic							'
Input capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz, see fig. 5}$		-	980	-	pF
Output capacitance	C _{oss}			-	140	-	
Reverse transfer capacitance	C _{rss}			-	50	-	
Total gate charge	Q_g	V _{GS} = 10 V	I _D = 3.1 A, V _{DS} =400 V, see fig. 6 and 13 ^b	-	-	80	nC
Gate-source charge	Q _{gs}			-	-	10	
Gate-drain charge	Q _{gd}	1		-	-	42	
Turn-on delay time	t _{d(on)}			-	12	-	
Rise time	t _r	V_{DD} = 500 V, I_{D} = 3.1 A R_{g} = 12 Ω , R_{D} = 170 Ω , see fig. 10 b		-	25	-	- ns
Turn-off delay time	t _{d(off)}			-	89	-	
Fall time	t _f			-	29	-	
Gate input resistance	R_g	f = 1 MHz, open drain		0.4	-	1.8	Ω
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		ı	4.5	-	nН
Internal source inductance	L _S			-	7.5	-	11111
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	I _S	showing the	MOSFET symbol showing the		-	3.1	А
Pulsed diode forward current ^a	I _{SM}	integral reverse p - n junction diode		-	-	12	^
Body diode voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 3.1 \text{A}, V_{GS} = 0 \text{V}^{ \text{b}}$		-	-	1.8	V
Body diode reverse recovery time	t _{rr}	T _J = 25 °C, I _F = 3.1 A, dl/dt = 100 A/μs b		-	410	620	ns
Body diode reverse recovery charge	Q _{rr}			-	1.3	2.0	μC
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_I				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

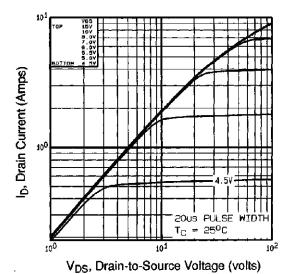


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

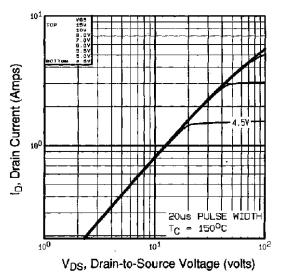


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

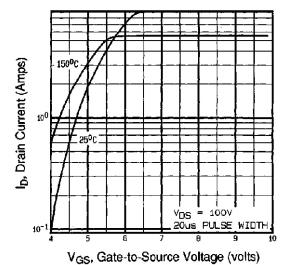


Fig. 3 - Typical Transfer Characteristics

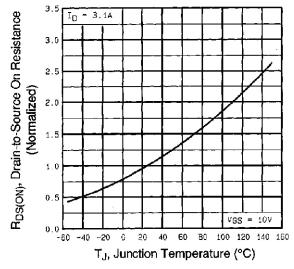


Fig. 4 - Normalized On-Resistance vs. Temperature



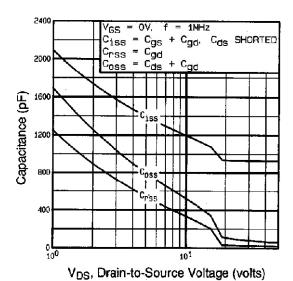


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

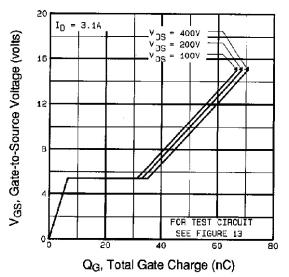


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

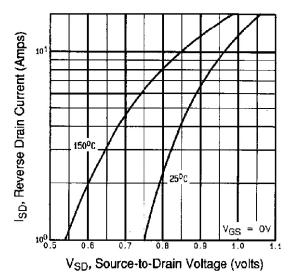


Fig. 7 - Typical Source-Drain Diode Forward Voltage

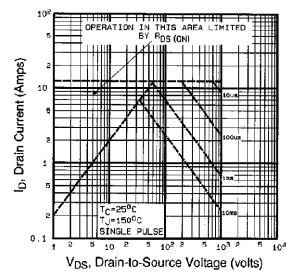


Fig. 8 - Maximum Safe Operating Area



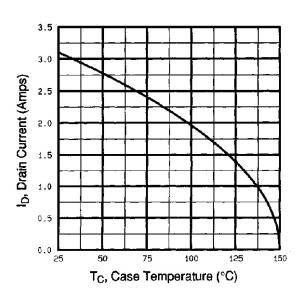


Fig. 9 - Maximum Drain Current vs. Case Temperature

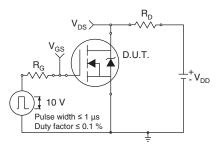


Fig. 10a - Switching Time Test Circuit

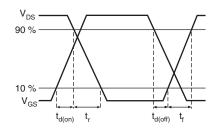


Fig. 10b - Switching Time Waveforms

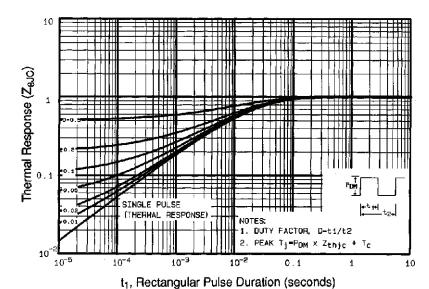


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

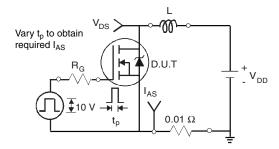


Fig. 12a - Unclamped Inductive Test Circuit

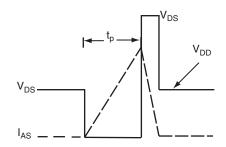


Fig. 12b - Unclamped Inductive Waveforms



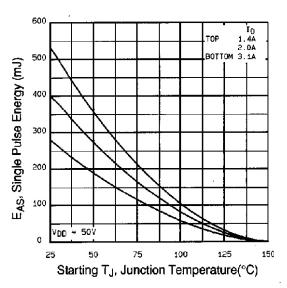


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

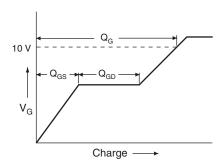


Fig. 13a - Basic Gate Charge Waveform

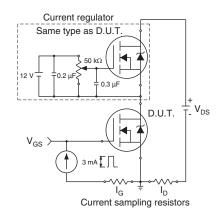
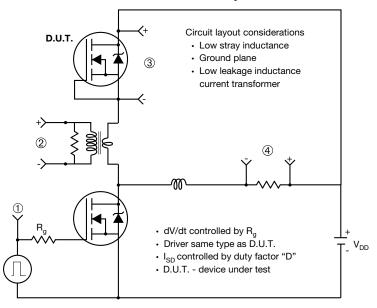


Fig. 13ab- Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



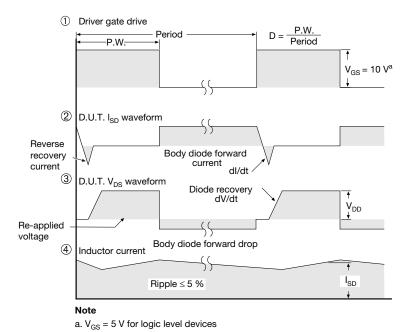


Fig. 14 - For N-Channel

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